# Logitech, Inc. MN: F-0550A

August 02, 2006

Report No. LABT0203.1

**Report Prepared By** 



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### **Certificate of Test**

Issue Date: August 02, 2006 Logitech, Inc.

Model: MN: F-0550A

	Emissions					
Test Description	Specification	Test Method	Pass	Fail		
AC Powerline Conducted Emissions	FCC 15.207	ANSI C63.4:2003	$\boxtimes$			
Occupied Bandwidth	FCC 15.247:2006	ANSI C63.4:2003	$\square$			
Output Power	FCC 15.247:2006	ANSI C63.4:2003	$\square$			
Power Spectral Density	FCC 15.247:2006	ANSI C63.4:2003	$\boxtimes$			
Spurious Conducted Emissions	FCC 15.247:2006	ANSI C63.4:2003	$\square$			
Spurious Radiated Emissions	FCC 15.247:2006	ANSI C63.4:2003	$\boxtimes$			
Band Edge Compliance	FCC 15.247:2006	ANSI C63.4:2003	$\boxtimes$			

Modifications made to the product See the Modifications section of this report

#### Test Facility

The measurement facility used to collect the data is located at:

Northwest EMC, Inc. 22975 NW Evergreen Parkway, Suite 400; Hillsboro, OR 97124 Phone: (503) 844-4066 Fax: 844-3826

This site has been fully described in a report filed with and accepted by the FCC (Federal Communications Commission) and Industry Canada.

Approved By:
ATU.K.P
Greg Kiemel, Director of Engineering

This report must not be used to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government of the United States of America.

Product compliance is the responsibility of the client, therefore the tests and equipment modes of operation represented in this report were agreed upon by the client, prior to testing. This Report may only be duplicated in its entirety. The results of this test pertain only to the sample(s) tested, the specific description is noted in each of the individual sections of the test report supporting this certificate of test.



Revision Number	Description	Date	Page Number
00	None		



**FCC:** Accredited by NVLAP for performance of FCC radio, digital, and ISM device testing. Our Open Area Test Sites, certification chambers, and conducted measurement facilities have been fully described in reports filed with the FCC and accepted by the FCC in letters maintained in our files. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by the FCC as a Telecommunications Certification Body (TCB). This allows Northwest EMC to certify transmitters to FCC specifications in accordance with 47 CFR 2.960 and 2.962.

**NVLAP:** Northwest EMC, Inc. is accredited under the United States Department of Commerce, National Institute of Standards and Technology, and National Voluntary Laboratory Accreditation Program for satisfactory compliance with the requirements of ISO/IEC 17025 for Testing Laboratories. The NVLAP accreditation encompasses Electromagnetic Compatibility Testing in accordance with the European Union EMC Directive 89/336/EEC, ANSI C63.4, MIL-STD 461E, DO-160D and SAE J1113. Additionally, Northwest EMC is accredited by NVLAP to perform radio testing in accordance with the European Union R&TTE Directive 1999/5/EEC, the requirements of FCC, and the RSS radio standards for Industry Canada.

**Industry Canada:** Accredited by NVLAP for performance of Industry Canada RSS and ICES testing. Our Open Area Test Sites and certification chambers comply with RSS 212, Issue 1 (Provisional) and have been filed with Industry Canada and accepted. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by NIST and recognized by Industry Canada as a Certification Body (CB) per the APEC Mutual Recognition Arrangement (MRA). This allows Northwest EMC to certify transmitters to Industry Canada technical requirements.

**CAB:** Designated by NIST and validated by the European Commission as a Conformity Assessment Body (CAB) to conduct tests and approve products to the EMC directive and transmitters to the R&TTE directive, as described in the U.S. - EU Mutual Recognition Agreement.

**TÜV Product Service:** Included in TUV Product Service Group's Listing of Recognized Laboratories. It qualifies in connection with the TUV Certification after Recognition of Agent's Testing Program for the product categories and/or standards shown in TUV's current Listing of CARAT Laboratories, available from TUV. A certificate was issued to represent that this laboratory continues to meet TUV's CARAT Program requirements. Certificate No. USA0401C.

**TÜV Rheinland:** Authorized to carryout EMC tests by order and under supervision of TÜV Rheinland. This authorization is based on "Conditions for EMC-Subcontractors" of November 1992.





NVLAP LAB CODE 200629-0 NVLAP LAB CODE 200630-0 NVLAP LAB CODE 200676-0









**NEMKO:** Assessed and accredited by NEMKO (Norwegian testing and certification body) for European emissions and immunity testing. As a result of NEMKO's laboratory assessment, they will accept test results from Northwest EMC, Inc. for product certification (Authorization No. ELA 119).

**Australia/New Zealand:** The National Association of Testing Authorities (NATA), Australia has been appointed by the ACA as an accreditation body to accredit test laboratories and competent bodies for EMC standards. Accredited test reports or assessments by competent bodies must carry the NATA logo. Test reports made by an overseas laboratory that has been accredited for the relevant standards by an overseas accreditation body that has a Mutual Recognition Agreement (MRA) with NATA are also accepted as technical grounds for product conformity. The report should be endorsed with the respective logo of the accreditation body (NVLAP).

**VCCI:** Accepted as an Associate Member to the VCCI, Acceptance No. 564. Conducted and radiated measurement facilities have been registered in accordance with Regulations for Voluntary Control Measures, Article 8. (*Registration Numbers. - Hillsboro: C-1071, R-1025, and R-2318, Irvine: C-2094 and R-1943, Sultan: R-871, C-1784 and R-1761).* 

**BSMI:** Northwest EMC has been designated by NIST and validated by C-Taipei (BSMI) as a CAB to conduct tests as described in the APEC Mutual Recognition Agreement. License No.SL2-IN-E-1017.

**GOST:** Northwest EMC, Inc. has been assessed and accredited by the Russian Certification bodies Certinform VNIINMASH, CERTINFO, SAMTES, and Federal CHEC, to perform EMC and Hygienic testing for Information Technology Products. As a result of their laboratory assessment, they will accept test results from Northwest EMC, Inc. for product certification

SCOPE For details on the Scopes of our Accreditations, please visit: http://www.nwemc.com/scope.asp

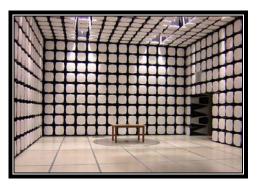












California – Orange County Facility Labs OC01 – OC13

41 Tesla Ave. Irvine, CA 92618 (888) 364-2378 Fax: (503) 844-3826





Oregon – Evergreen Facility Labs EV01 – EV11

22975 NW Evergreen Pkwy. Suite 400 Hillsboro, OR 97124 (503) 844-4066 Fax: (503) 844-3826





Washington – Sultan Facility Labs SU01 – SU07

14128 339<sup>th</sup> Ave. SE Sultan, WA 98294 (888) 364-2378



# **Product Description**

Party Requesting the Test	
Company Name:	Logitech, Inc.
Address:	1499 SE Tech Center Place Suite 350
City, State, Zip:	Vancouver, WA 98683
Test Requested By:	Mitchell Phillipi
Model:	MN: F-0550A
First Date of Test:	7/19/2006
Last Date of Test:	8/1/2006
Receipt Date of Samples:	7/19/2006
Equipment Design Stage:	Production
Equipment Condition:	No Damage

### Information Provided by the Party Requesting the Test

#### Functional Description of the EUT (Equipment Under Test): The F-0550A is a Bluetooth USB dongle.

### **Testing Objective:**

To satisfy the requirements of FCC 15.247.

#### EUT Photo



# Configurations

### **CONFIGURATION 1 LABT0203**

Software/Firmware Running during test		
Description	Version	
Windows Media Player 10	10.00.00.3646	

EUT					
Description	Manufacturer	Model/Part Number	Serial Number		
EUT Dongle	Logitech, Inc.	F-0550A	Unknown		

Peripherals in test setup boundary					
Description	Manufacturer	nufacturer Model/Part Number Serial Number			
Parallel Printer	Epson	P930A	3HR1045240		
Monitor	IBM	6558-03N	55-70151		
Host PC	Dell	Dimension 1100	H163W81		
Mouse	Logitech, Inc.	M-CAA42	LZA14813499		
Keyboard	Gateway	2196003	15410263		
Dongle Cradle	Logitech, Inc.	Unknown	Unknown		
Wireless Headset	Logitech, Inc.	F-0399A	Unknown		

Cables					
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
AC Power	No	2.0m	No	AC Mains	Parallel Printer
Parallel	No	1.8m	No	Parallel Printer	Host PC
AC Power	No	1.8m	No	AC Mains	Monitor
Video	PA	1.6m	Yes	Monitor	Host PC
AC Power	No	1.6m	No	AC Mains	Host PC
USB	PA	2.0m	No	Host PC	Dongle Cradle
Keyboard	PA	1.8m	No	Keyboard	Host PC
Mouse	PA	1.8m	No	Mouse	Host PC
PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.					

### **CONFIGURATION 2 LABT0203**

Software/Firmware Running during test			
Description	Version		
Blue Test Application	1.22		

EUT					
Description	Manufacturer	Model/Part Number	Serial Number		
EUT Dongle	Logitech, Inc.	F-0550A	Unknown		

Peripherals in test setup boundary					
Description	Manufacturer	Model/Part Number	Serial Number		
Monitor	IBM	6558-03N	55-70151		
Dongle Cradle	Logitech, Inc.	Unknown	Unknown		
Power Adapter	Dell	AA20031	CN-03694U-16291-14G-0ASD		
Notebook PC	Dell	Latitude C400	C2MCL21		
Motherboard	CASIRA	Unknown	5777		

# Configurations

Cables					
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
AC Power	No	1.8m	No	AC Mains	Monitor
Video	PA	1.6m	Yes	Monitor	Host PC
AC Power	No	1.6m	No	AC Mains	Power Adapter
DC Power	No	1.8m	Yes	Power Adapter	Laptop
Serial	No	2.0m	No	Motherboard	Laptop
Ribbon	No	1.6m	No	Motherboard	Unterminated
AC Power	No	1.4m	No	AC Mains	Motherboard
USB	PA	2.0m	No	Laptop	Dongle Cradle
PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.					

CONFIGURATION 3 LABT0203

Software/Firmware Running during test	
Description	Version
Blue Test Application	1.22

EUT					
Description	Manufacturer	Model/Part Number	Serial Number		
EUT Dongle	Logitech, Inc.	F-0550A	Unknown		

Remote Equipment Outside of Test Setup Boundary				
Description	Manufacturer	Model/Part Number	Serial Number	
Notebook PC	Dell	Latitude C400	C2MCL21	
Development Module	Cambridge Silicon Radio, Ltd.	BCES301199/1	7467 08 08 03	

Cables					
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
USB	PA	2.0m	No	Host PC	Dongle Cradle
PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown					

### **CONFIGURATION 4 LABT0203**

Software/Firmware Running during test			
Description	Version		
Blue Test Application	1.22		

EUT			
Description	Manufacturer	Model/Part Number	Serial Number
EUT Dongle	Logitech, Inc.	F-0550A	Unknown

Remote Equipment Outside of Test Setup Boundary				
Description	Manufacturer	Model/Part Number	Serial Number	
Notebook PC	Dell	Latitude C400	C2MCL21	
Development Module	Cambridge Silicon Radio, Ltd.	BCES301199/1	7467 08 08 03	

Cables					
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
USB	PA	2.0m	No	Host PC	Dongle Cradle
PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.					



# Modifications

	Equipment modifications						
Item	Date	Test	Modification	Note	Disposition of EUT		
1	7/19/2006	AC Powerline Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
2	7/19/2006	Radiated Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
3	7/20/2006	Spurious Radiated Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
4	7/20/2006	AC Powerline Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
5	7/21/2006	Occupied Bandwidth	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
6	7/21/2006	Output Power	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
7	7/21/2006	Band Edge Compliance	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
8	7/21/2006	Power Spectral Density	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
9	7/24/2006	Spurious Emissions of the Receiver	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.		
10	8/1/2006	Spurious Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	Scheduled testing was completed.		

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT						
Description	Manufacturer	Model	ID	Last Cal.	Interval	
Spectrum Analyzer	Hewlett-Packard	8593E	AAN	1/25/2006	13	

#### MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

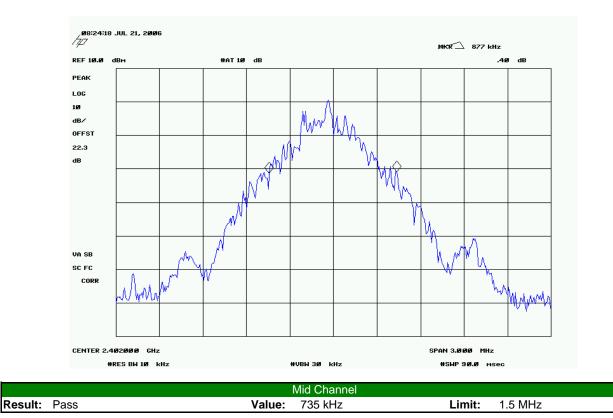
#### TEST DESCRIPTION

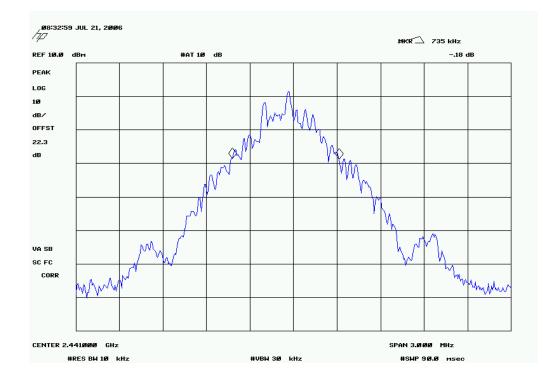
The occupied bandwidth was measured with the EUT set to low, medium, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode.

NORTHWEST EMC		OCCUPIED E	BANDV	VIDTH				XMit 2006.05.31
	F-0550A					Work Order	r: LABT0203	
Serial Number:	Unknown					Date	: 07/21/06	
	Logitech, Inc.					Temperature		
Attendees:						Humidity		
Project:					Barc	ometric Pres		
	Rod Peloquin			120VAC/60Hz		Job Site	e: EV06	
TEST SPECIFICAT				Test Method				
FCC 15.247:2006 F	HSS			ANSI C63.4:2003, DA 0	0-705:2000			
COMMENTS								
User power level s								
DEVIATIONS FROM	M TEST STANDARD							
Configuration #	4	Signature Rocky la	Releng					
						Value	Limit	Results
Low Channel						877 kHz	1.5 MHz	Pass
Mid Channel						735 kHz	1.5 MHz	Pass
High Channel						780 kHz	1.5 MHz	Pass

### **OCCUPIED BANDWIDTH**

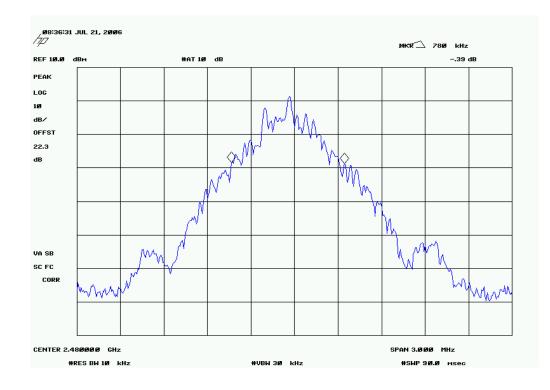
		Low Channel		
Result: Pass	Value	877 kHz	Limit:	1.5 MHz





## **OCCUPIED BANDWIDTH**

		ł	High Channel			
Result:	Pass	Value:	780 kHz	Limit:	1.5 MHz	





# OCCUPIED BANDWIDTH





Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Hewlett-Packard	8593E	AAN	1/25/2006	13
Power Meter	Hewlett Packard	E4418A	SPA	7/23/2004	27
Power Sensor	Hewlett-Packard	8481H	SPB	10/23/2004	24
Signal Generator	Hewlett-Packard	8648D	TGC	1/27/2006	13

#### MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

#### TEST DESCRIPTION

The peak output power was measured with the EUT set to low, medium, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and a spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode.

De Facto EIRP Limit: Per 47 CFR 15.247 (b)(1-3), the EUT meets the de facto EIRP limit of +36dBm.

NORTHWEST EMC		OUTPUT	POW	ER				XMit 2006.05.31
EUT:	F-0550A				V	Vork Order:	LABT0203	
Serial Number:	Unknown					Date:	07/21/06	
Customer:	Logitech, Inc.				Te	mperature:	24°C	
Attendees:	None					Humidity		
Project:	N/A				Barom	etric Pres.:	30.11	
	Rod Peloquin		Power:	120VAC/60Hz		Job Site:	EV06	
TEST SPECIFICATI	ONS			Test Method			• •	
FCC 15.247:2006 FI	HSS			ANSI C63.4:2003, DA 0	0-705:2000			
COMMENTS								
User power level se								
Configuration #	4	Signature Rocky to	. Reling	>				
						Value	Limit	Results
Low Channel						2.81 mW	1 Watt	Pass
Mid Channel					:	2.87 mW	1 Watt	Pass
High Channel					:	2.89 mW	1 Watt	Pass

Low Channel					
Result: Pass	Value: 2.81 mW	Limit: 1 Watt			



Mid Channel					
Result: Pass	Value: 2.87 mW	Limit:	1 Watt		



		High Channel		
Result: Pass	Value:	2.89 mW Lir	mit:	1 Watt







Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT								
Description	Manufacturer	Model	ID	Last Cal.	Interval			
Spectrum Analyzer	Hewlett-Packard	8593E	AAN	1/25/2006	13			

#### MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

#### TEST DESCRIPTION

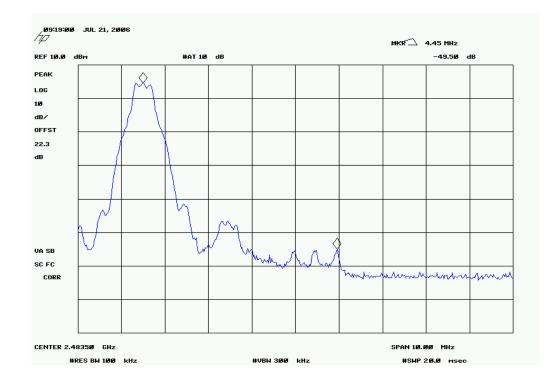
The spurious RF conducted emissions at the edges of the authorized band were measured with the EUT set to low and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode. The channels closest to the band edges were selected. The spectrum was scanned across each band edge from 5 MHz below the band edge to 5 MHz above the band edge.

NORTHWEST		BAND EDGE C				XMit 2006.05.31
EMC		DAND EDGE C	OWFLIANCE			
EUT:	F-0550A			Work Order:	LABT0203	
Serial Number:					07/21/06	
	Logitech, Inc.			Temperature:		
Attendees:				Humidity:		
Project:				Barometric Pres.:	30.11	
	Rod Peloquin		Power: 120VAC/60Hz	Job Site:	EV06	
TEST SPECIFICATI	IONS		Test Method			
FCC 15.247:2006 FI	HSS		ANSI C63.4:2003, DA 00	-705:2000		
COMMENTS						
DEVIATIONS FROM	I TEST STANDARD					
		201	Pl			
Configuration #	4	Rocky le	Lereng			
		Signature	V			
				Value	Limit	Results
Low Channel				-45.9 dBc	≤ -20 dBc	Pass
High Channel				-49.5 dBc	≤ -20 dBc	Pass

### **BAND EDGE COMPLIANCE**

	Low	/ Channel	
Result: Pass	Value: -4	5.9 dBc Limit:	≤ -20 dBc







# BAND EDGE COMPLIANCE



Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT								
Description	Manufacturer	Model	ID	Last Cal.	Interval			
Spectrum Analyzer	Agilent	E4446A	AAT	4/4/2006	12			

#### MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

#### TEST DESCRIPTION

NORTHWEST

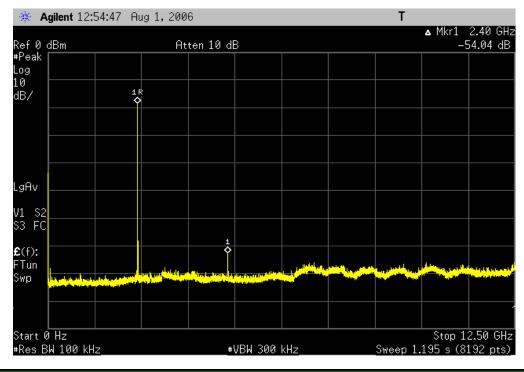
EMC

The spurious RF conducted emissions were measured with the EUT set to low, medium, and high transmit frequencies. The measurements were made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode. For each transmit frequency, the spectrum was scanned throughout the specified frequency.

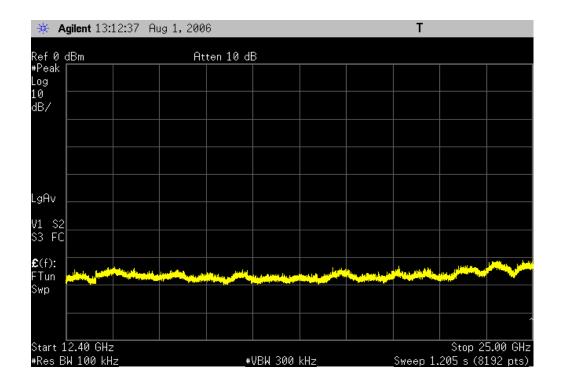
NORTHWEST						XMit 2006.05.31
EMC		SPURIOUS CONDUCTED	EMISSIONS			
	T: F-0550A			Work Order:	LABT0203	
Serial Numbe					08/01/06	
	r: Logitech, Inc.			Temperature:		
Attendees				Humidity:		
Projec				Barometric Pres.:		
	y: Rod Peloquin	Power:	120VAC/60Hz	Job Site:		
TEST SPECIFICA			Test Method	005 010.	2101	
FCC 15.247:2006			ANSI C63.4:2003, DA 00-70	)5·2000		
100 13.247.2000	11166		74101 000.4.2000, D7100 74	0.2000		
COMMENTS						
COMMENTO						
DEVIATIONS FRO	OM TEST STANDARD					
Configuration #		Rocky to Releng				
Configuration #	4		>			
		Signature				
				Value	Limit	Results
Low Channel				value	Linin	Results
LOW GHAIIIEI	0MHz - 12.5GHz			-54.0 dBc	≤ -20 dBc	Pass
	12.4GHz-25GHz			< -50 dBc	≤ -20 dBc ≤ -20 dBc	Pass
Mid Channel	12.4GHZ-25GHZ			< -50 dBc	≤ -20 uBC	Pass
wid Channel	0MHz - 12.5GHz			E4.4 dDo	≤ -20 dBc	Pass
Lish Obergel	12.4GHz-25GHz			< -50 dBc	≤ -20 dBc	Pass
High Channel				47.0 dD-	< 00 dDa	Deee
	0MHz - 12.5GHz				≤ -20 dBc	Pass
	12.4GHz-25GHz			< -50 dBc	≤ -20 dBc	Pass

### SPURIOUS CONDUCTED EMISSIONS

	Low Channel, 0MHz - 12.5GHz		
Result: Pass	Value: -54.0 dBc	Limit:	≤ -20 dBc

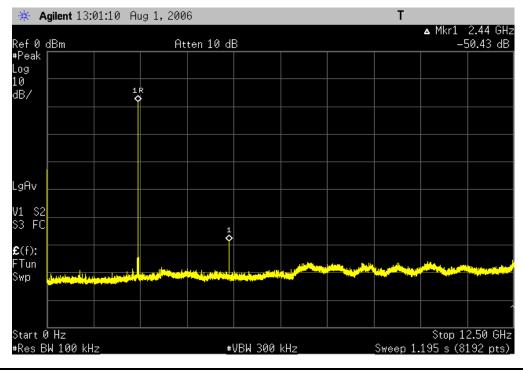


	Low Channel, 12.4GHz-25GHz		
Result: Pass	<b>Value:</b> < -50 dBc	Limit:	≤ -20 dBc

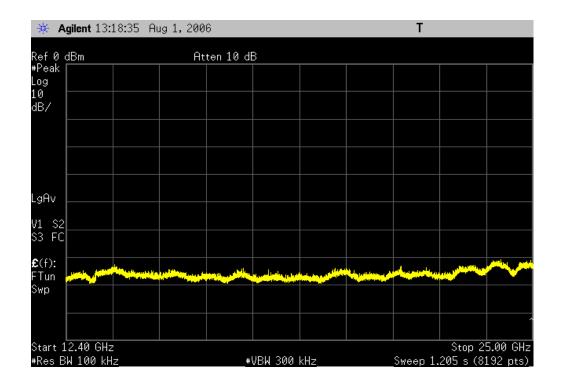


### SPURIOUS CONDUCTED EMISSIONS

	Mid Channel, 0MHz - 12.5GHz	
Result: Pass	Value: -54.4 dBc	<b>Limit:</b> ≤ -20 dBc

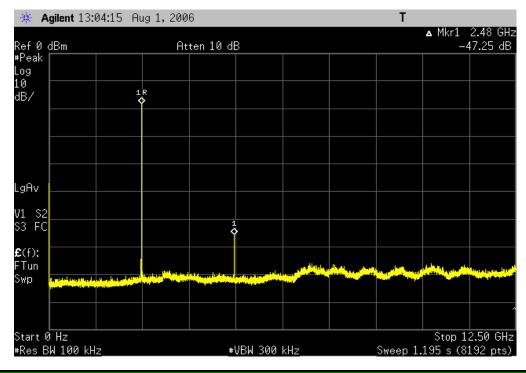


	Mid Channel, 12.4GHz-25GHz		
Result: Pass	Value: < -50 dBc	Limit:	≤ -20 dBc

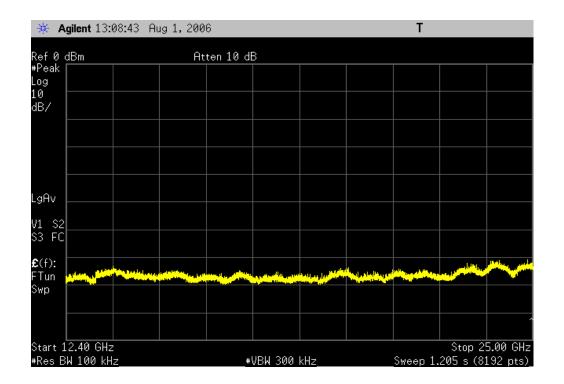


### SPURIOUS CONDUCTED EMISSIONS

	High Channel, 0MHz - 12.5GHz		
Result: Pass	Value: -47.3 dBc	Limit:	≤ -20 dBc



	High Channel, 12.4GHz-25GHz		
Result: Pass	<b>Value:</b> < -50 dBc	Limit:	≤ -20 dBc



NORTHWEST

# SPURIOUS CONDUCTED EMISSIONS

XMit 2006.05.31



Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Hewlett-Packard	8593E	AAN	1/25/2006	13
Power Meter	Hewlett Packard	E4418A	SPA	7/23/2004	27
Power Sensor	Hewlett-Packard	8481H	SPB	10/23/2004	24
Signal Generator	Hewlett-Packard	8648D	TGC	1/27/2006	13

#### MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

#### TEST DESCRIPTION

The peak power spectral density measurements were measured with the EUT set to low, mid, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate using direct sequence modulation. Per the procedure outlined in FCC 97-114, the spectrum analyzer was used as follows:

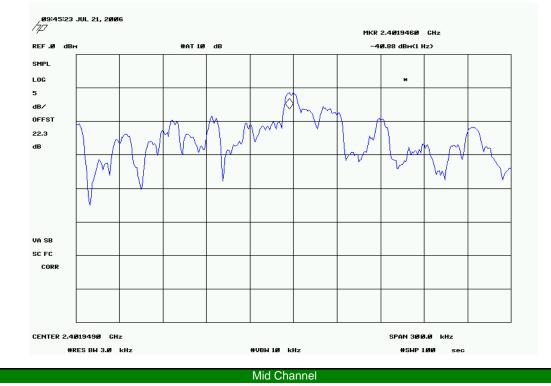
The emission peak(s) were located and zoom in on within the passband. The resolution bandwidth was set to 3 kHz, the video bandwidth was set to greater than or equal to the resolution bandwidth. The sweep speed was set equal to the span divided by 3 kHz (sweep = (SPAN/3 kHz)). For example, given a span of 1.5 MHz, the sweep should be 1.5 x  $10^6 \div 3 \times 10^3 = 500$  seconds. External attenuation was used and added to the reading. The following FCC procedure was used for modifying the power spectral density measurements:

"If the spectrum line spacing cannot be resolved on the available spectrum analyzer, the noise density function on most modern conventional spectrum analyzers will directly measure the noise power density normalized to a 1 Hz noise power bandwidth. Add 34.8 dB for correction to 3 kHz."

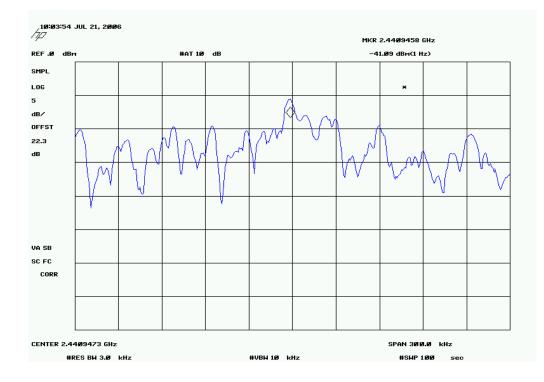
NORTHWEST EMC		POWER SPEC		DENSITY			XMit 2006.05.31
EUT:	F-0550A				Work Order:	LABT0203	
Serial Number:	Unknown				Date:	07/21/06	
	Logitech, Inc.				Temperature:		
Attendees:	None				Humidity:	40%	
Project:	N/A				Barometric Pres.:	30.11	
	Rod Peloquin		Power:	120VAC/60Hz	Job Site:	EV06	
TEST SPECIFICATI	ONS			Test Method			
FCC 15.247:2006 D	TS			ANSI C63.4:2003, KDB	No. 558074		
COMMENTS							
DEVIATIONS FROM	I TEST STANDARD						
Configuration #	4	Signature Rocky	e Reling				
					Value Li	mit	Results
Low Channel				-6.08 dBm		/ 3 kHz	Pass
Mid Channel				-6.29 dBm		/ 3 kHz	Pass
High Channel				-6.59 dBm	/ 3 kHz 8 dBm	/ 3 kHz	Pass

# POWER SPECTRAL DENSITY

			Low Channel			
Result:	Pass	Value:	-6.08 dBm / 3 kHz	Limit:	8 dBm / 3 kHz	

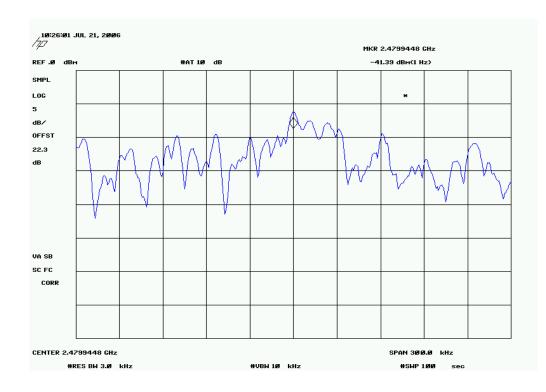






# POWER SPECTRAL DENSITY

		ł	High Channel			
Result:	Pass	Value:	-6.59 dBm / 3 kHz	Limit:	8 dBm / 3 kHz	



NORTHWEST

# POWER SPECTRAL DENSITY



# SPURIOUS RADIATED EMISSIONS

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MODES OF OPERATION
TX high channel
TX mid channel
TX low channel

#### POWER SETTINGS INVESTIGATED

120VAC/60Hz

NORTHWEST

**EMC** 

FREQUENCY RANGE INVESTIGATED					
Start Frequency	30MHz	Stop Frequency	26.5GHz		

#### CLOCKS AND OSCILLATORS 2.48MHz

#### SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Antenna, Biconilog	EMCO	3141	AXE	12/28/2005	24
Antenna, Horn	EMCO	3115	AHC	8/30/2005	12
Pre-Amplifier	Miteq	AMF-4D-010100-24-10P	APW	8/2/2005	13
High Pass Filter	Micro-Tronics	HPM50111	HFO	4/4/2006	13
Pre-Amplifier	Miteq	AM-1616-1000	AOL	1/4/2006	13
Spectrum Analyzer	Agilent	E4446A	AAT	4/4/2006	12

#### **MEASUREMENT BANDWIDTHS**

Frequency Range	Peak Data	Quasi-Peak Data	Average Data
(MHz)	(kHz)	(kHz)	(kHz)
0.01 - 0.15	1.0	0.2	0.2
0.15 - 30.0	10.0	9.0	9.0
30.0 - 1000	100.0	120.0	120.0
Above 1000	1000.0	N/A	1000.0
Measurements were made us	ing the bandwidths and de	ectors specified. No video filter	was used.

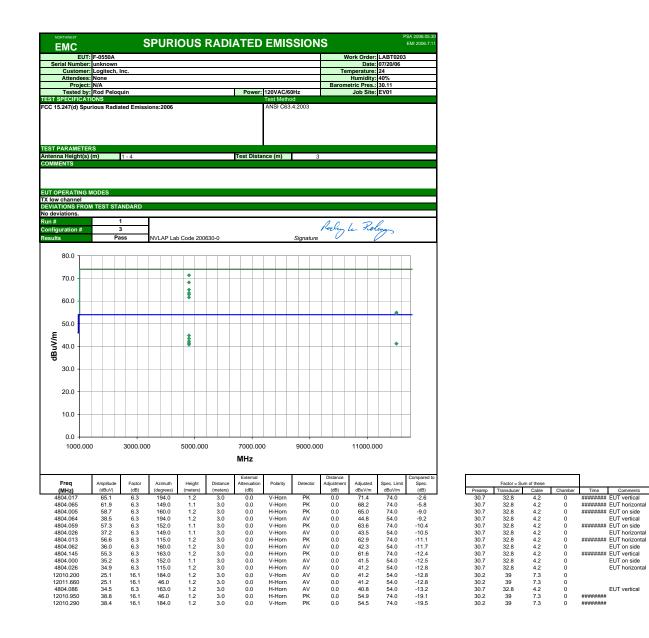
#### MEASUREMENT UNCERTAINTY

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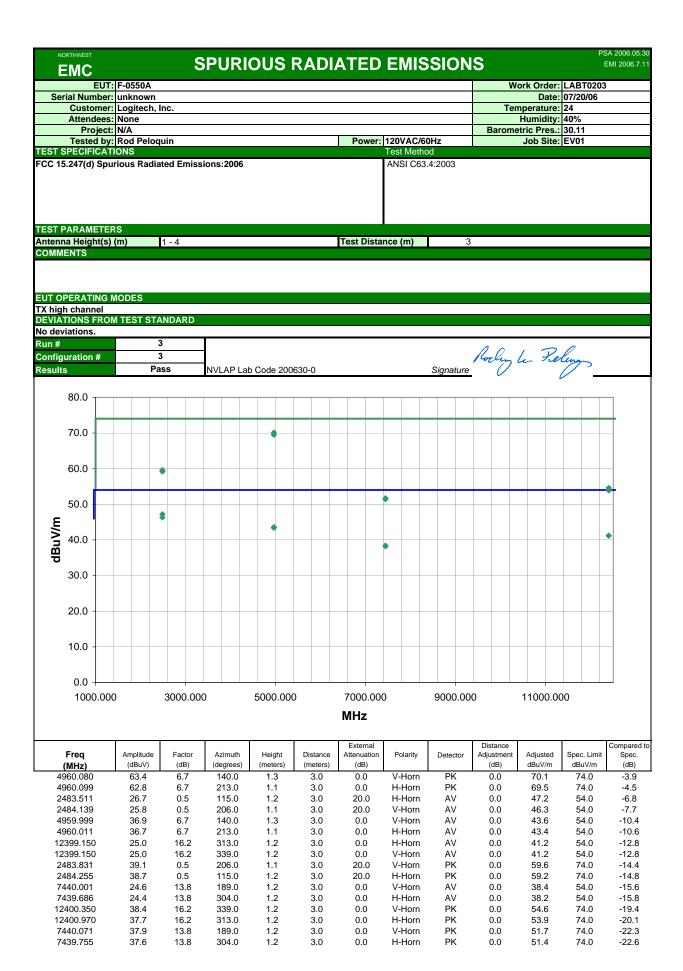
#### TEST DESCRIPTION

The highest gain of each type of antenna to be used with the EUT was tested. The EUT was configured for low, mid, and high band transmit frequencies. For each configuration, the spectrum was scanned throughout the specified range. In addition, measurements were made in the restricted bands to verify compliance. While scanning, emissions from the EUT were maximized by rotating the EUT on a turntable, adjusting the position of the EUT and the EUT antenna in three orthogonal axis, and adjusting measurement antenna height and polarization, and manipulating the EUT antenna in 3 orthogonal planes (per ANSI C63.4:2003). A preamp and high pass filter were used for this test in order to provide sufficient measurement sensitivity.

#### PSA 2006.05.3



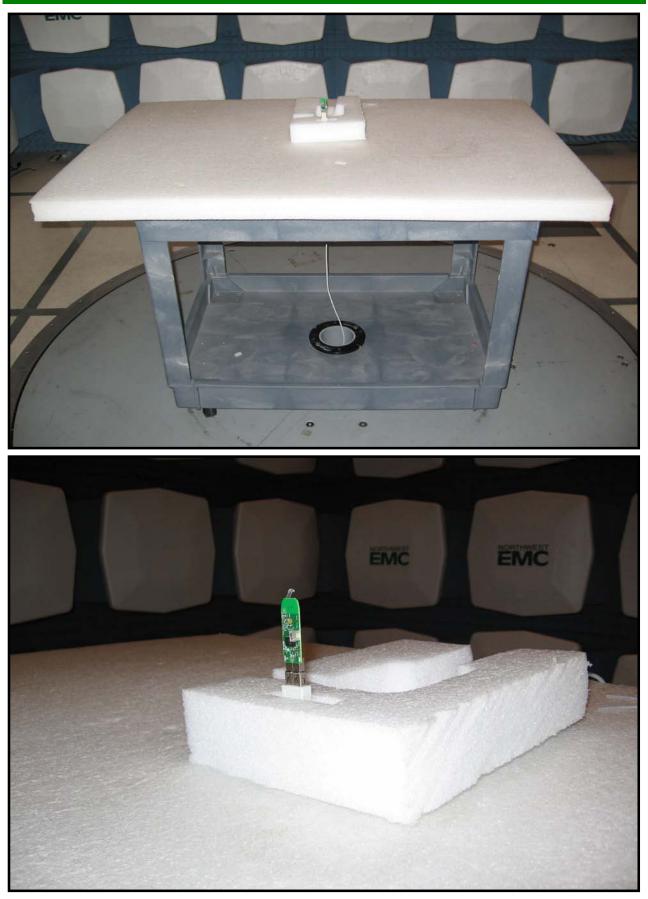
	orthwest			S	PURI	0 <u>US</u>	RADI	ATED	EMIS	SION	S		P	SA 2006.05.30 EMI 2006.7.11
		IT-IF	-0550A									ork Order	LABT020	3
Se	rial Numb	_		1							VV		07/20/06	3
	Custom										Tei	mperature		
	Attende											Humidity:		
	Proje Tested I			auin				Power	120VAC/6	047	Baromo	etric Pres.: Job Site:		
TEST S	SPECIFIC			quin				T OWCI.	Test Metho			oob one.		
		-		iated Emiss	ions:2006				ANSI C63	.4:2003				
	PARAMET na Height(			1 - 4				Test Dista	nce (m)	3				
СОММ		( <b>U</b> ) (II	·,	1 7				TOOL DIGIT	inee (iii)	Ů				
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	viations.		IESI S	IANDARD										
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Config	guration #			3							Porty	In he	leng	
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	70.0 -					*								
	60.0		•											
dBuV/m	50.0							•						
	40.0		•			*							•	<u> </u>
σ	30.0													
	20.0													
	10.0													
	0.0 🗕													
	1000.0	000		3000.00	0	5000.00	0	7000.00	0	9000.00	0	11000.0	00	
	MHz													
	Freq (MHz)		Amplitude (dBuV)	(dB)	Azimuth (degrees)	Height (meters)	Distance (meters)	External Attenuation (dB)	Polarity	Detector	Distance Adjustment (dB)	Adjusted dBuV/m	Spec. Limit dBuV/m	(dB)
	882.140 882.062		65.0 63.8	6.5 6.5	132.0 216.0	1.2 1.2	3.0 3.0	0.0 0.0	V-Horn H-Horn	PK PK	0.0 0.0	71.5 70.3	74.0 74.0	-2.5 -3.7
	881.980		38.7	6.5	132.0	1.2	3.0	0.0	V-Horn	AV	0.0	45.2	54.0	-8.8
48	882.021		37.8	6.5	216.0	1.2	3.0	0.0	H-Horn	AV	0.0	44.3	54.0	-9.7
	626.045		24.3	-2.7	162.0	1.1	3.0	20.0	V-Horn	AV	0.0	41.6	54.0	-12.4
	625.943 2208.010		24.0 25.0	-2.7 16.2	197.0 126.0	1.3 1.0	3.0 3.0	20.0 0.0	H-Horn V-Horn	AV AV	0.0 0.0	41.3 41.2	54.0 54.0	-12.7 -12.8
12208.010 12204.720			25.0 24.9	16.2	86.0	1.0	3.0	0.0	H-Horn	AV	0.0	41.2	54.0 54.0	-12.8
73	7324.310		24.7	13.4	69.0	1.0	3.0	0.0	H-Horn	AV	0.0	38.1	54.0	-15.9
	326.250		24.7	13.4	137.0	1.1	3.0	0.0	V-Horn	AV	0.0	38.1	54.0	-15.9
	626.187		38.3 38.1	-2.7	162.0	1.1	3.0	20.0	V-Horn	PK	0.0	55.6	74.0 74.0	-18.4 -18.6
	626.306 2206.310		38.1 38.7	-2.7 16.2	197.0 126.0	1.3 1.0	3.0 3.0	20.0 0.0	H-Horn V-Horn	PK PK	0.0 0.0	55.4 54.9	74.0 74.0	-18.6 -19.1
	2206.110		37.8	16.2	86.0	1.3	3.0	0.0	H-Horn	PK	0.0	54.0	74.0	-20.0
73	323.077		38.4	13.4	137.0	1.1	3.0	0.0	V-Horn	PK	0.0	51.8	74.0	-22.2
7:	323.125		38.2	13.4	69.0	1.0	3.0	0.0	H-Horn	PK	0.0	51.6	74.0	-22.4





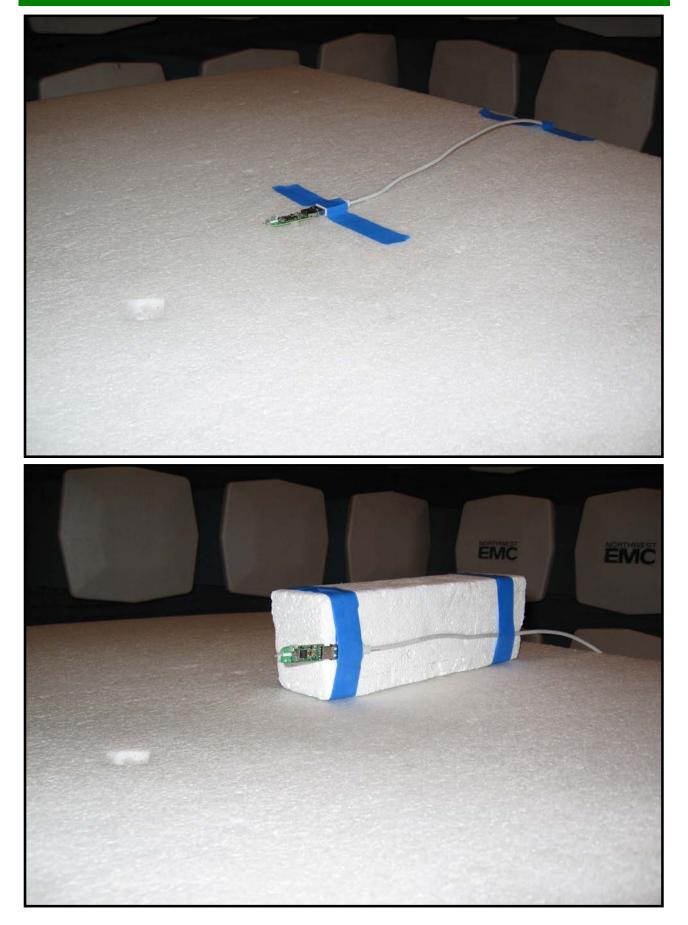
## SPURIOUS RADIATED EMISSIONS

PSA 2006.05.30





## SPURIOUS RADIATED EMISSIONS



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MODES OF OPERATION	
TX high channel	
TX mid channel	
TX low channel	

### POWER SETTINGS INVESTIGATED

120V/60Hz

#### SAMPLE CALCULATIONS

Conducted Emissions: Adjusted Level = Measured Level + Transducer Factor + Cable Attenuation Factor + External Attenuator

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Terminator	S.M. Electronics	ST3B	TMD	5/17/2006	13
Attenuator	Tektronix	011-0059-02	ATH	12/19/2005	13
High Pass Filter	TTE	H97-100k-50-720B	HFC	12/19/2005	13
LISN	Solar	9252-50-R-24-BNC	LIQ	12/13/2005	13
LISN	Solar	9252-50-R-24-BNC	LIP	12/13/2005	13
Receiver	Rohde & Schwartz	ESCI	ARG	7/22/2006	12

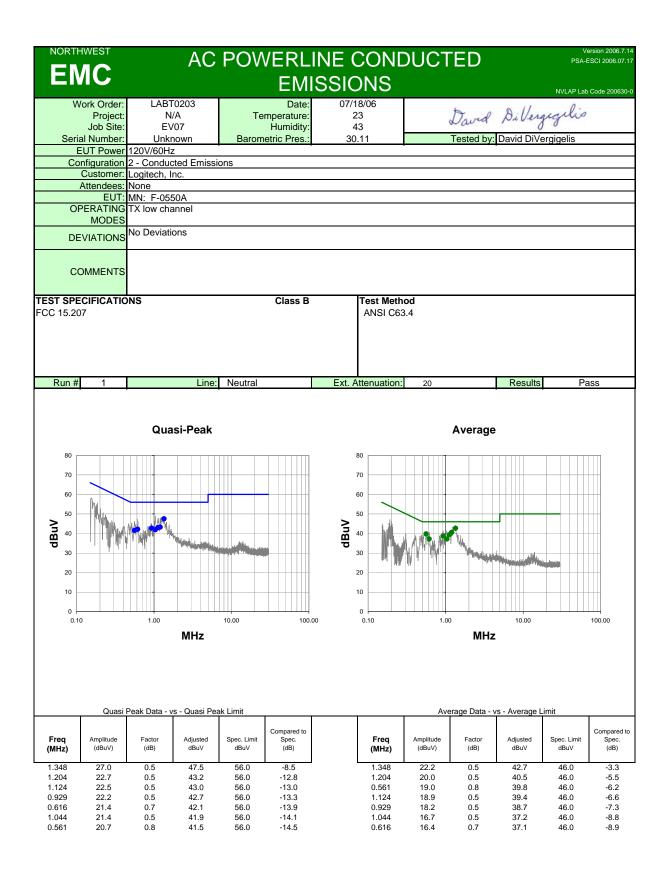
EASUREMENT BANDWIDTHS						
Frequency Range	Peak Data	Quasi-Peak Data	Average Data			
(MHz)	(kHz)	(kHz)	(kHz)			
0.01 - 0.15	1.0	0.2	0.2			
0.15 - 30.0	10.0	9.0	9.0			
30.0 - 1000	100.0	120.0	120.0			
Above 1000	1000.0	N/A	1000.0			
Measurements were made usi	ng the bandwidths and det	ectors specified No video filte	r was used			

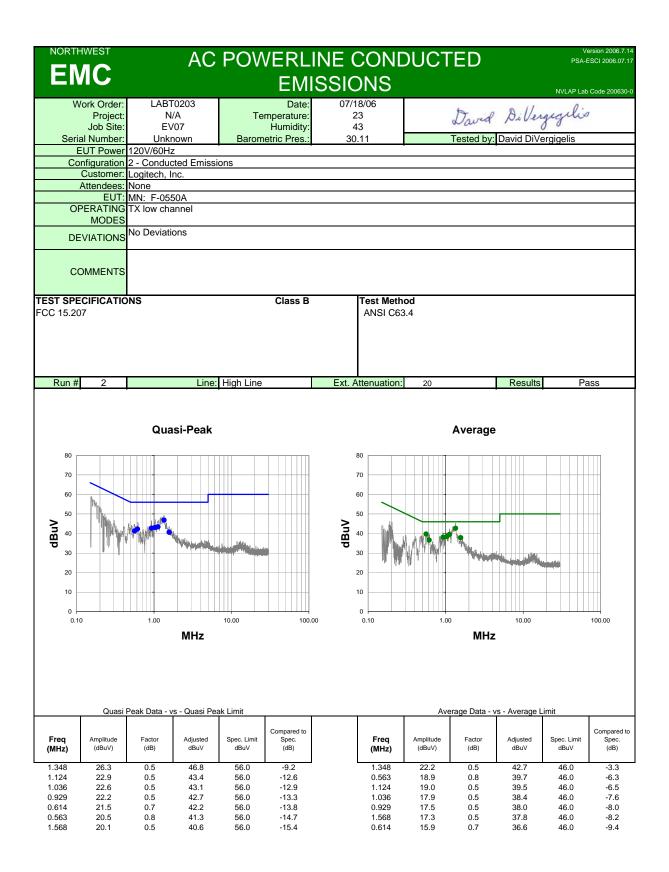
#### MEASUREMENT UNCERTAINTY

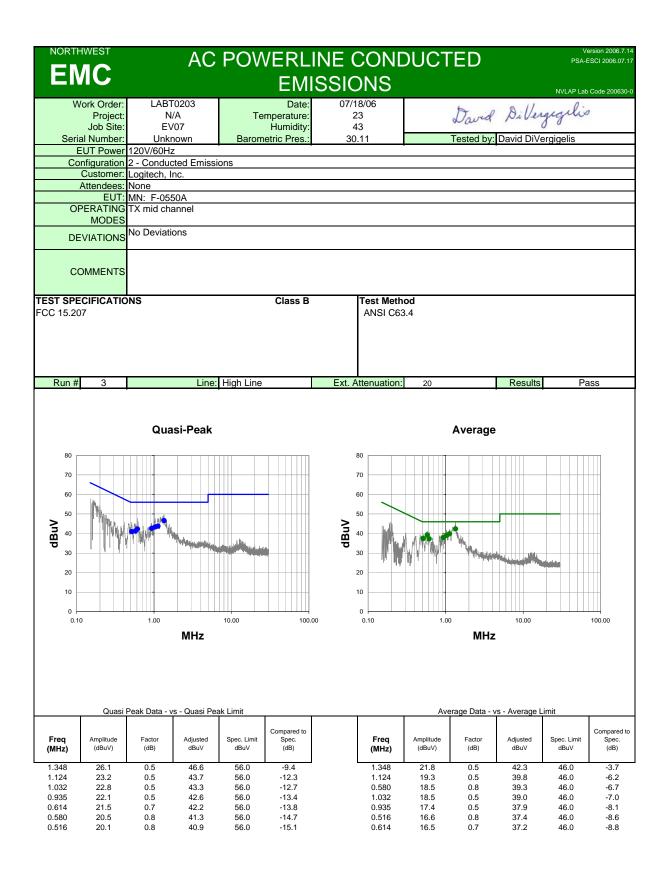
Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

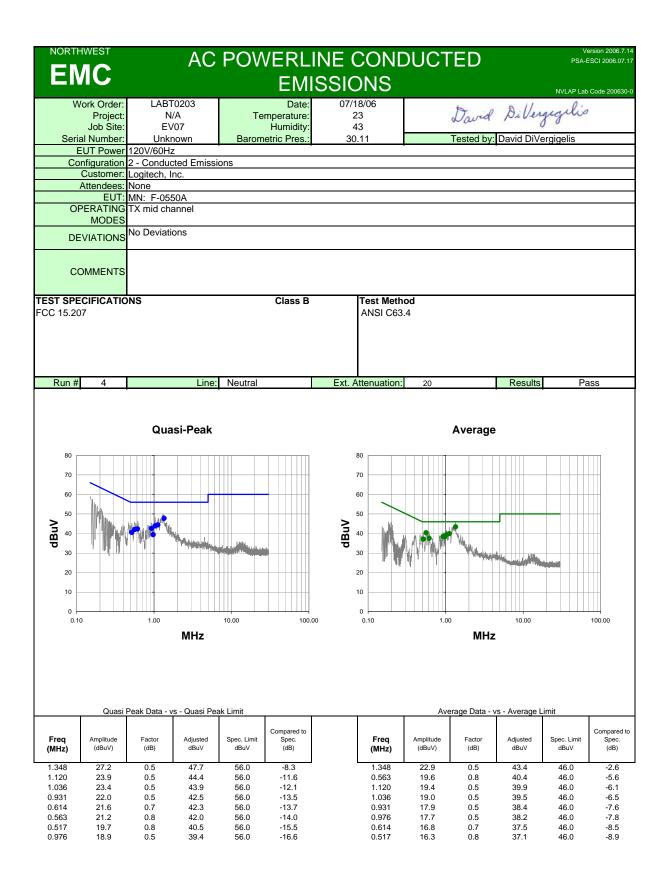
#### **TEST DESCRIPTION**

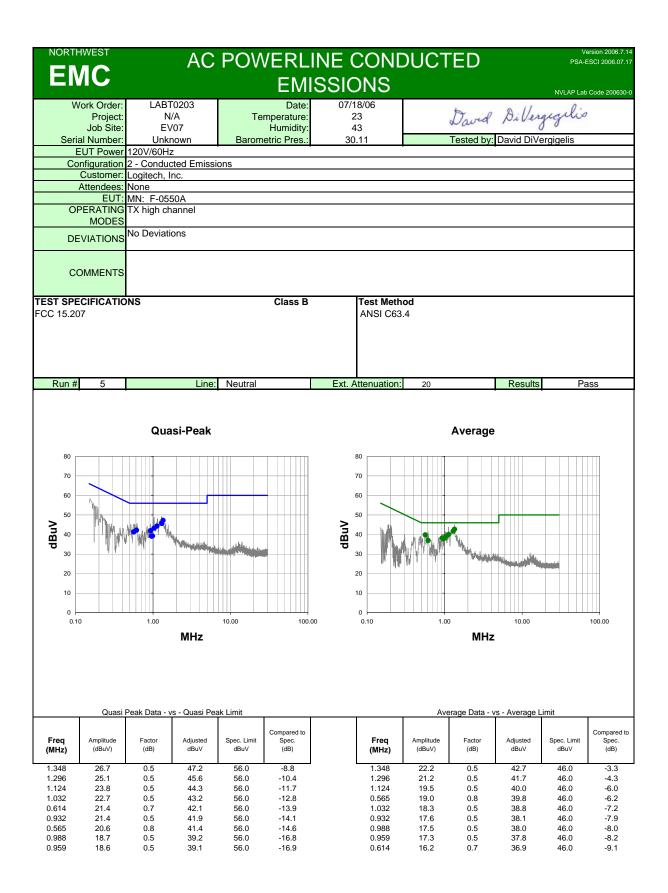
Using the mode of operation and configuration noted within this report, conducted emissions tests were performed. The frequency range investigated (scanned), is also noted in this report. Conducted power line measurements are made, unless otherwise specified, over the frequency range from 150 kHz to 30 MHz to determine the line-to-ground radio-noise voltage that is conducted from the EUT power-input terminals that are directly (or indirectly via separate transformer or power supplies) connected to a public power network. Equipment is tested with power cords that are normally used or that have electrical or shielding characteristics that are the same as those cords normally used. Typically those measurements are made using a LISN (Line Impedance Stabilization Network), the 50  $\Omega$  measuring port is terminated by a 50  $\Omega$  EMI meter or a 50  $\Omega$  resistive load. All 50  $\Omega$  measuring ports of the LISN are terminated by 50 $\Omega$ .

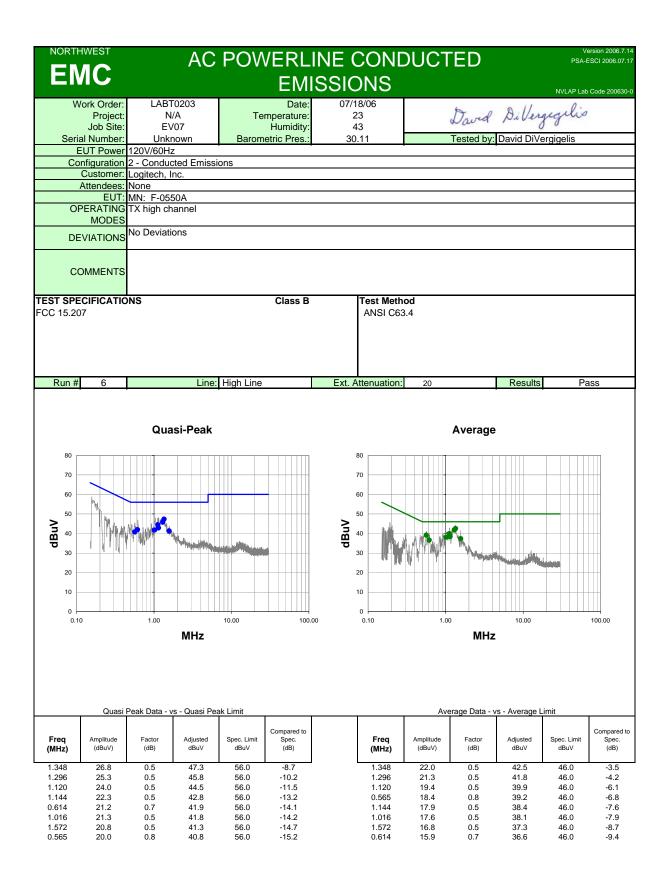














#### BLUETOOTH APPROVALS FCC Procedure Received from Joe Dichoso on 2-15-02

The following exhibit indicates the FCC Spread Spectrum requirements in Section 15.247 for devices meeting the Bluetooth Specifications in the 2.4 GHz band as of February 2001 operating in the USA. The purpose of this exhibit is to help expedite the approval process for Bluetooth devices. This exhibit provides items that vary for each device and also provides a list of items that are common to Bluetooth devices that explains the remaining requirements. The list of common items can be submitted for each application for equipment authorization. This exhibit only specifies requirements in Section 15.247, requirements in other rule Sections for intentional radiators such as in Section 15.203 or 15.207 must be also be addressed. A Bluetooth device is a FHSS transmitter in the data mode and applies as a Hybrid spread spectrum device in the acquisition mode.

For each individual device, the following items, 1-7 will vary from one device to another and must be submitted.

- 1) The occupied bandwidth in Section 15.247(a)(1)(ii).
- 2) Conducted output power specified in Section 15.247(b)(1).
- 3) EIRP limit in Section 15.247(b)(3).
- 4) RF safety requirement in Section 15.247(b)(4)
- 5) Spurious emission limits in Section 15.247(c).
- 6) Processing gain and requirements for Hybrids in Section 15.247(f) in the acquisition mode.
- 7) Power spectral density requirement in Section 15.247(f) in the acquisition mode.

For all devices, the following items, 1-12, are common to all Bluetooth devices and will not vary from one device to another. This list can be copied into the filing.

# 1 Output power and channel separation of a Bluetooth device in the different operating modes:

The different operating modes (data-mode, acquisition-mode) of a Bluetooth device don't influence the output power and the channel spacing. There is only one transmitter which is driven by identical input parameters concerning these two parameters.

Only a different hopping sequence will be used. For this reason, the RF parameters in one op-mode is sufficient.

### 2 Frequency range of a Bluetooth device:

The maximum frequency of the device is: 2402 - 2480 MHz.

This is according the Bluetooth Core Specification V 1.0B (+ critical errata) for devices which will be operated in the USA. Other frequency ranges (e.g. for Spain, France, Japan) which are allowed according the Core Specification must **not be** supported by the device.

# 3 Co-ordination of the hopping sequence in data mode to avoid simultaneous occupancy by multiple transmitters:

Bluetooth units which want to communicate with other units must be organized in a structure called piconet. This piconet consist of max. 8 Bluetooth units. One unit is the master the other seven are the slaves. The master co-ordinates frequency occupation in this piconet for all units. As the master hop sequence is derived from it's BD address which is unique for every Bluetooth device, additional masters intending to establish new piconets will always use different hop sequences.

4 Example of a hopping sequence in data mode:

### Example of a 79 hopping sequence in data mode:

40, 21, 44, 23, 42, 53, 46, 55, 48, 33, 52, 35, 50, 65, 54, 67, 56, 37, 60, 39, 58, 69, 62, 71, 64, 25, 68, 27, 66, 57, 70, 59, 72, 29, 76, 31, 74, 61, 78, 63, 01, 41, 05, 43, 03, 73, 07, 75, 09, 45, 13, 47, 11, 77, 15, 00, 64, 49, 66, 53, 68, 02, 70, 06, 01, 51, 03, 55, 05, 04

# 5 Equally average use of frequencies in data mode and short transmissions:

The generation of the hopping sequence in connection mode depends essentially on two input values:

1. LAP/UAP of the master of the connection

2. Internal master clock

The LAP (lower address part) are the 24 LSB's of the 48 BD\_ADDRESS. The BD\_ADDRESS is an unambiguous number of every Bluetooth unit. The UAP (upper address part) are the 24 MSB's of the 48 BD\_ADDRESS. The internal clock of a Bluetooth unit is derived from a free running clock which is never adjusted and is never turned off. For synchronization with other units, only the offsets are used. It has no relation to the time of the day. Its resolution is at least half the RX/TX slot length of 312.5 µs. The clock has a cycle of about one day (23h30). In most case it is implemented as 28 bit counter. For the deriving of the hopping sequence the entire LAP (24 bits), 4 LSB's (4 bits) (Input 1) and the 27 MSB's of the clock (Input 2) are used. With this input values different mathematical procedures (permutations, additions, XOR-operations) are performed to generate the sequence. This will be done at the beginning of every new transmission.

Regarding short transmissions, the Bluetooth system has the following behavior: The first connection between the two devices is established, a hopping sequence is generated. For transmitting the wanted data, the complete hopping sequence is not used and the connection ends. The second connection will be established. A new hopping sequence is generated. Due to the fact that the Bluetooth clock has a different value, because the period between the two transmission is longer (and it cannot be shorter) than the minimum resolution of the clock (312.5  $\mu$ s). The hopping sequence will always differ from the first one.

# 6 Receiver input bandwidth, synchronization and repeated single or multiple packets:

The input bandwidth of the receiver is 1 MHz.

In every connection, one Bluetooth device is the master and the other one is the slave. The master determines the hopping sequence (see chapter 5). The slave follows this sequence. Both devices shift between RX and TX time slot according to the clock of the master. Additionally the type of connection (e.g. single or multi-slot packet) is set up at the beginning of the connection. The master adapts its hopping frequency and its TX/RX timing is according to the packet type of the connection. Also, the slave of the connection uses these settings. Repeating of a packet has no influence on the hopping sequence. The hopping sequence generated by the master of the connection will be followed in any case. That means, a repeated packet will not be send on the same frequency, it is send on the next frequency of the hopping sequence

### 7 Dwell time in data mode

The dwell time of 0.3797s within a 30 second period in data mode is independent from the packet type (packet length). The calculation for a 30 second period is a follows: Dwell time = time slot length \* hop rate / number of hopping channels \*30s Example for a DH1 packet (with a maximum length of one time slot) Dwell time = 625  $\mu$ s \* 1600 1/s / 79 \* 30s = 0.3797s (in a 30s period) For multi-slot packet the hopping is reduced according to the length of the packet. Example for a DH5 packet (with a maximum length of five time slots)

Dwell time = 5 \* 625  $\mu$ s \* 1600 \* 1/5 \*1/s / 79 \* 30s = 0.3797s (in a 30s period) This is according the Bluetooth Core Specification V 1.0B (+ critical errata) for all Bluetooth devices. Therefore, all Bluetooth devices **comply** with the FCC dwell time requirement in the data mode.

This was checked during the Bluetooth Qualification tests.

The Dwell time in hybrid mode is approximately 2.6 mS (in a 12.8s period)

### 8 Channel Separation in hybrid mode

The nominal channel spacing of the Bluetooth system is 1Mhz independent of the operating mode.

The maximum "initial carrier frequency tolerance" which is allowed for Bluetooth is fcenter = 75 kHz.

This was checked during the Bluetooth Qualification tests (Test Case: TRM/CA/07-E) for three frequencies (2402, 2441, 2480 MHz).

### 9 Derivation and examples for a hopping sequence in hybrid mode

For the generation of the inquiry and page hop sequences the same procedures as described for the data mode are used (see item 5), but this time with different input vectors:

\*\*For the inquiry hop sequence, a predefined fixed address is always used. This results in the same 32 frequencies used by all devices doing an inquiry but every time with a different start frequency and phase in this sequence.

\*\*For the page hop sequence, the device address of the paged unit is used as the input vector. This results in the use of a subset of 32 frequencies which is specific for that initial state of the connection establishment between the two units. A page to different devices would result in a different subset of 32 frequencies.

So it is ensured that also in hybrid mode, the frequency is used equally on average. Example of a hopping sequence in inquiry mode:

48, 50, 09, 13, 52, 54,41, 45, 56, 58, 11, 15, 60, 62, 43, 47, 00, 02, 64, 68, 04, 06, 17, 21, 08, 10, 66, 70, 12, 14, 19, 23

Example of a hopping sequence in paging mode:

08, 57, 68, 70, 51, 02, 42, 40, 04, 61, 44, 46, 63, 14, 50, 48, 16, 65, 52, 54, 67, 18, 58, 56, 20, 53, 60, 62, 55, 06, 66, 64

### 10 Receiver input bandwidth and synchronization in hybrid mode:

The receiver input bandwidth is the same as in the data mode (1 MHz). When two Bluetooth devices establish contact for the first time, one device sends an inquiry access code and the other device is scanning for this inquiry access code. If two devices have been connected previously and want to start a new transmission, a similar procedure takes place. The only difference is, instead of the inquiry access code, a special access code, derived from the BD\_ADDRESS of the paged device will be, will be sent by the master of this connection. Due to the fact that both units have been connected before (in the inquiry procedure) the paging unit has timing and frequency information about the page scan of the paged unit. For this reason the time to establish the connection is reduced.

### 11 Spread rate / data rate of the direct sequence signal

The Spread rate / Data rate in inquiry and paging mode can be defined via the access code. The access code is the only criterion for the system to check if there is a valid transmission or not. If you regard the presence of a valid access code as one bit of information, and compare it with the length of the access code of 68 bits, the Spread rate / Data rate will be 68/1.

12 Spurious emission in hybrid mode

The Dwell in hybrid mode is shorter than in data mode. For this reason the spurious emissions average level in data mode is worst case. The spurious emissions peak level is the same for both modes.